N-Channel 40V, 1.2mΩ Typ. Power MOSFET

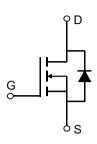
Description

Features

• 40V, 250A

 $R_{DS(ON)}$ Typ = 1.2m Ω @ V_{GS} = 10V

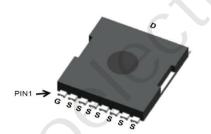
- Advanced Split Gate Trench Technology
- Excellent R_{DS(ON)} and Low Gate Charge
- 100% UIS TESTED!
- 100% ΔVds TESTED!

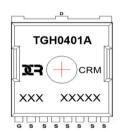




Application

- Load Switch
- PWM Application
- Power Management





Marking and Pin Assignment

Package Marking and Ordering Information

Device	Marking	Package	Outline	Reel Size	Reel (pcs)	Per Carton (pcs)
CRMTGH0401A	CRMTGH0401A	TOLL	TAPING	13"	2000	10000

Absolute Maximum Ratings (@ $T_J = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter		Value	Units
V_{DS}	Drain-to-Source Voltage		40	V
V_{GS}	Gate-to-Source Voltage		±20	V
	Continuous Drain Current	T _C = 25°C	250	Α
I _D	Continuous Drain Current	T _C = 100°C	150	Α
I _{DM}	Pulsed Drain Current (1)		1000	Α
E _{AS}	Single Pulsed Avalanche Energy (2)		576	mJ
P_{D}	Power Dissipation	T _C = 25°C	156	W
$R_{ hetaJC}$	Thermal Resistance, Junction to Case		0.8	°C/W
T_J,T_STG	Junction & Storage Temperature Range		-55 to 150	°C



N-Channel 40V, 1.2mΩ Typ. Power MOSFET

Electrical Characteristics (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
_	acteristics	Conditions	1411111	ıyp.	mux.	Oilit
	Drain-Source Breakdown Voltage	I _D = 250μA, V _{GS} = 0V	40	_		V
V _{(BR)DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 40V, V_{GS} = 0V$			1.0	
I _{DSS}		20 00	-			μΑ
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
	acteristics					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	2.4	3	3.6	V
$R_{DS(ON)}$	Static Drain-Source ON-Resistance ⁽³⁾	$V_{GS} = 10V, I_D = 30A$	-	1.2	1.5	mΩ
Dynamic	Characteristics					
C_{iss}	Input Capacitance		-	4495	-	pF
C_{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 20V,$ f = 1MHz	-	2100	-	pF
C_{rss}	Reverse Transfer Capacitance	1 – 11VII 12	X-\	213	-	pF
Q_g	Total Gate Charge		-	50	-	nC
Q_{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 20V, I_{D} = 50A$	U .	17	-	nC
Q_{gd}	Gate Drain("Miller") Charge	V _{DS} – 20V, I _D – 50A	-	14	-	nC
Switchin	g Characteristics					
t _{d(on)}	Turn-On DelayTime		-	10	-	ns
t_r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 20V$	-	5	-	ns
$t_{d(off)}$	Turn-Off DelayTime	$I_D = 50A, R_{GEN} = 1.6\Omega$	-	20	-	ns
t_f	Turn-Off Fall Time		-	6	-	ns
Drain-So	urce Diode Characteristics and M	Max Ratings				
I _S	Maximum Continuous Drain to Source Di	ode Forward Current	-	-	250	Α
I _{SM}	Maximum Pulsed Drain to Source Diode	Forward Current	-	-	1000	А
V _{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 30A$	-	-	1.2	V
trr	Body Diode Reverse Recovery Time		-	21	-	ns
Qrr	Body Diode Reverse Recovery Charge	$I_F = 50A$, di/dt = 100A/us	_	59	_	nC
~	,,,,,					

Notes:

^{1.} Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

^{2.} E_{AS} condition: Starting T_J =25°C, V_{DD} =20V, V_G =10V, R_G =25ohm, L=0.5mH, I_{AS} =48A

^{3.} Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%.



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Typical Performance Characteristics

Figure 1: Output Characteristics

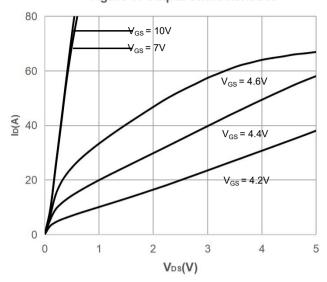


Figure 3: On-resistance vs. Drain Current

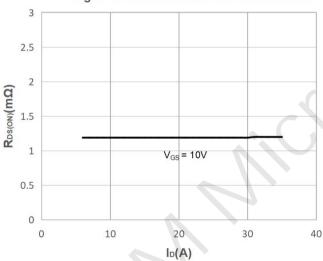


Figure 5: Gate Charge Characteristics

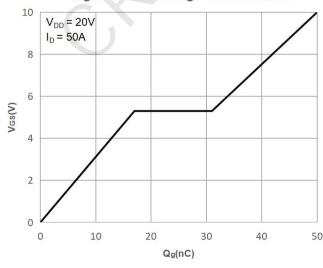


Figure 2: Typical Transfer Characteristics

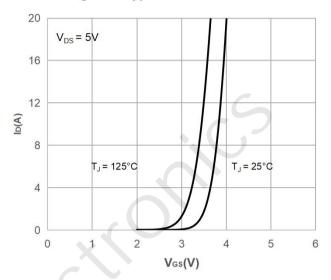


Figure 4: Body Diode Characteristics

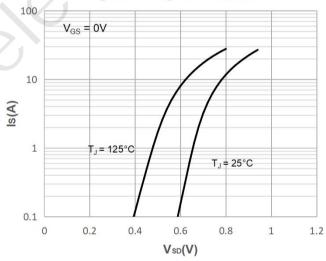
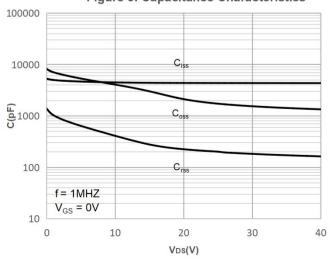


Figure 6: Capacitance Characteristics



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Typical Performance Characteristics

Figure 7: Normalized Breakdown voltage vs.

Junction Temperature

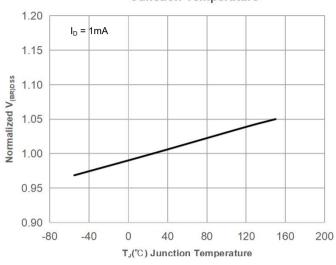


Figure 9: Maximum Safe Operating Area

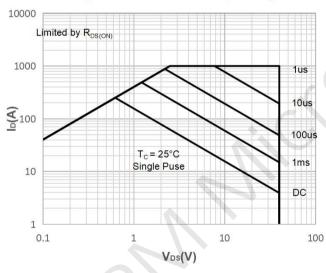


Figure 11: Normalized Maximum Transient

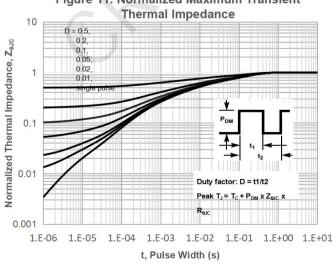


Figure 8: Normalized on Resistance vs. Junction Temperature

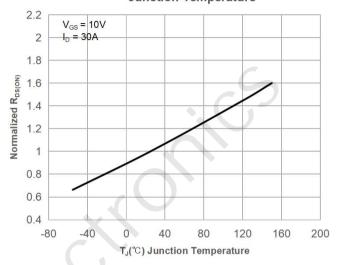


Figure 10: Maximum Continuous Drian
Current vs. Case Temperature

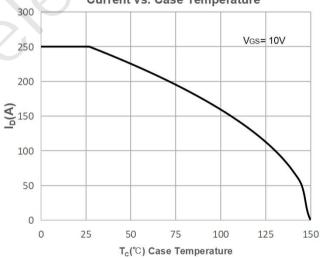
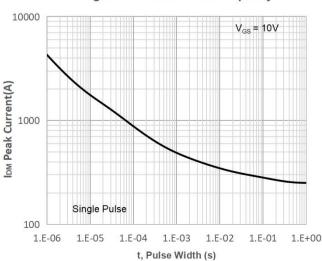


Figure 12: Peak Current Capacity



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Test Circuit

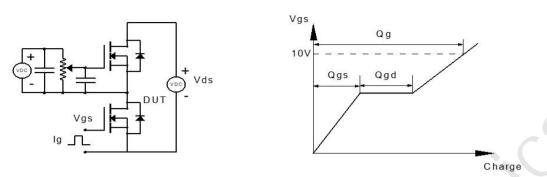


Figure 1: Gate Charge Test Circuit & Waveform

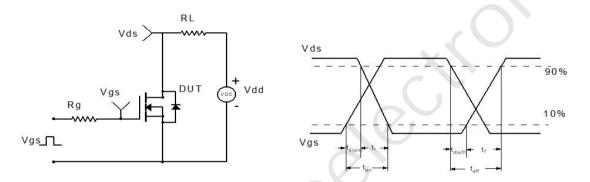


Figure 2: Resistive Switching Test Circuit & Waveform

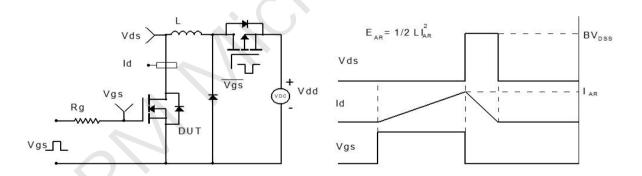


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

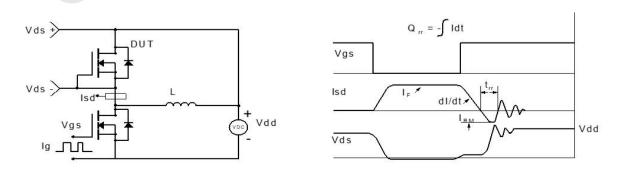
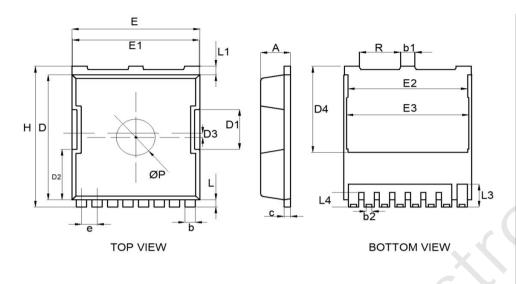


Figure 4: Diode Recovery Test Circuit & Waveform

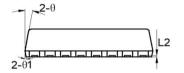
N-Channel 40V, 1.2mΩ Typ. Power MOSFET

Package Mechanical Data(TOLL)



SYMBOL	MILLIMETER					
SIMDUL	MIN	NOM	MAX			
A	2.20	2. 20 2. 30				
b	0.60	0.70	0.80			
b1	1.10	1.10 1.20				
b2	0.36 REF.					
С	0.40 0.50 0.6					
D	10. 30	10. 40	10.50			
D1	3. 20	3.30	3. 40			
D2	4. 08	4. 18	4. 28			
D3	0. 53 0. 63		0.73			
D4	7.35 REF.					
E	9.80	9. 90	10.00			
E1	9.70	9.80	9.90			
E2	8.80 REF.					
E3	8.95 REF.					
е	1.20 BSC.					
Н	11. 50 11. 70		11. 90			
L	0.50	0.60	0.70			
L1	0.60 0.70		0.80			
L2	0.10 REF.					
L3	1.27 REF.					
L4	1.10 REF.					
P	2.00	3.00	4. 00			
R	3.00	3. 10	3. 20			
θ	7°	9°	11°			
θ1	3°	5°	7°			

MILLIMETER



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